

Dated: February 22, 1996.

Susan G. Esserman,

Assistant Secretary for Import Administration.

[FR Doc. 96-4418 Filed 2-26-96; 8:45 am]

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[A-412-817]

Notice of Postponement of Preliminary Determination: Antidumping Duty Investigation of Foam Extruded PVC and Polystyrene Framing Stock From the United Kingdom

AGENCY: Import Administration, International Trade Administration, Department of Commerce.

FOR FURTHER INFORMATION CONTACT: Ellen Grebasch or Erik Warga, Office of Antidumping Investigations, Import Administration, U.S. Department of Commerce, 14th Street and Constitution Avenue, N.W., Washington D.C. 20230; telephone (202) 482-3773, or (202) 482-0922, respectively.

The Applicable Statute

Unless otherwise indicated, all citations to the statute are references to the provisions effective January 1, 1995, the effective date of the amendments made to the Tariff Act of 1930 (the Act) by the Uruguay Round Agreements Act (URAA)

Postponement of Preliminary Determination

On February 16, 1996, petitioner, Marley Mouldings, made a timely request that the Department of Commerce postpone until Friday, May 3, 1996, its preliminary determination in this investigation. Accordingly, pursuant to section 733(c)(1)(A) of the Act, we have done so.

This notice is published pursuant to section 733(c)(2) of the Act.

Dated: February 20, 1996.

Barbara R. Stafford,

Deputy Assistant Secretary for Investigations, Import Administration.

[FR Doc. 96-4419 Filed 2-26-96; 8:45 am]

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Florida International University, et al.; Notice of Consolidated Decision on Applications for Duty-Free Entry of Electron Microscopes

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 A.M. and 5:00 P.M. in

Room 4211, U.S. Department of Commerce, 14th and Constitution Avenue, N.W., Washington, D.C.

Docket Number: 95-100. *Applicant:* Florida International University, Miami, FL 33199. *Instrument:* Electron Microscope, Model CM200. *Manufacturer:* Philips, The Netherlands. *Intended Use:* See notice at 60 FR 58330, November 27, 1995. *Order Date:* December 27, 1994.

Docket Number: 95-102. *Applicant:* State University of New York at Buffalo, Amherst, NY 14260. *Instrument:* Electron Microscope, Model JEM-2010. *Manufacturer:* JEOL Ltd., Japan. *Intended Use:* See notice at 60 FR 58330, November 27, 1995. *Order Date:* March 17, 1995.

Docket Number: 95-107. *Applicant:* U.S. Department of Commerce, Gaithersburg, MD 20899. *Instrument:* Electron Microscope, Model CM300. *Manufacturer:* Philips, The Netherlands. *Intended Use:* See notice at 60 FR 62390, December 6, 1995. *Order Date:* September 16, 1994.

Docket Number: 95-108. *Applicant:* VA Medical Center of Gainesville, Gainesville, FL 32608-1197. *Instrument:* Electron Microscope, Model CM100. *Manufacturer:* Philips, The Netherlands. *Intended Use:* See notice at 60 FR 62390, December 6, 1995. *Order Date:* September 25, 1995.

Docket Number: 95-112. *Applicant:* The Scripps Research Institute, La Jolla, CA 92037. *Instrument:* Electron Microscope, Model CM100. *Manufacturer:* Philips, The Netherlands. *Intended Use:* See notice at 60 FR 62390, December 6, 1995. *Order Date:* August 29, 1995.

Comments: None received. *Decision:* Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as these instruments are intended to be used, was being manufactured in the United States at the time the instruments were ordered. *Reasons:* Each foreign instrument is a conventional transmission electron microscope (CTEM) and is intended for research or scientific educational uses requiring a CTEM. We know of no CTEM, or any other instrument suited to these purposes, which was being manufactured in the United States either at the time of order of each instrument or at the time of receipt of application by the U.S. Customs Service.

Frank W. Creel

Director, Statutory Import Programs Staff
[FR Doc. 96-4420 Filed 2-26-96; 8:45 am]

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Rutgers University, et al.; Notice of Consolidated Decision on Applications for Duty-Free Entry of Scientific Instruments

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 A.M. and 5:00 P.M. in Room 4211, U.S. Department of Commerce, 14th and Constitution Avenue, N.W., Washington, D.C.

Comments: None received. *Decision:* Approved. No instrument of equivalent scientific value to the foreign instruments described below, for such purposes as each is intended to be used, is being manufactured in the United States.

Docket Number: 95-101. *Applicant:* Rutgers University, Piscataway, NJ 08855. *Instrument:* Chlorophyll Fluorescence Measuring System, Model PAM 101. *Manufacturer:* Walz (Mess- und Regeltechnik), Germany. *Intended Use:* See notice at 60 FR 57222, November 14, 1995. *Reasons:* The foreign instrument provides: (1) fluorescence rate measurements under sunlight conditions, (2) flash trigger control variable between 100 msec and 10 000 sec, and (3) high kinetic resolution at 100 Hz. *Advice Received From:* National Institutes of Health, January 29, 1996.

Docket Number: 95-103. *Applicant:* University of Virginia, Charlottesville, VA 22906. *Instrument:* SIR Mass Spectrometer, Model OPTIMA. *Manufacturer:* Fisons Instruments, United Kingdom. *Intended Use:* See notice at 60 FR 58330, November 27, 1995. *Reasons:* The foreign instrument provides continuous flow gas chromatography-combustion and an internal precision of 0.01 per mil for 5 bar μ l of CO₂. *Advice Received From:* National Institutes of Health, January 30, 1996.

Docket Number: 95-106. *Applicant:* Pennsylvania State University, University Park, PA 16802. *Instrument:* Cold Stage for Time-of-Flight SIMS. *Manufacturer:* Kore Technology, Ltd., United Kingdom. *Intended Use:* See notice at 60 FR 62390, December 6, 1995. *Reasons:* The foreign instrument provides vibrational stability to allow imaging with spatial resolution to 20 nm and a demountable sample holder. *Advice Received From:* National Institutes of Health, January 30, 1996.

Docket Number: 95-110. *Applicant:* National Institutes of Standards and Technology, Gaithersburg, MD 20899. *Instrument:* Mass Spectrometer, Model